

MOSFET

Metal Oxide Semiconductor Field Effect Transistor

CoolMOS™ C7

650V CoolMOS™ C7 Power Transistor IPZ65R065C7

Data Sheet

Rev. 2.1 Final



IPZ65R065C7

1 Description

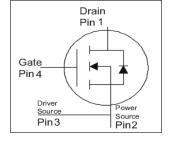
CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies.

CoolMOS™ C7 series combines the experience of the leading SJ MOSFET supplier with high class innovation. The product portfolio provides all benefits of fast switching superjunction MOSFETs offering better efficiency, reduced gate charge, easy implementation and outstanding reliability.

PG-TO 247-4

Features

- Increased MOSFET dv/dt ruggedness
- Better efficiency due to best in class FOM R_{DS(on)}*E_{oss} and R_{DS(on)}*Q_g
- Best in class R_{DS(on)} /package
- Easy to use/drive due to driver source pin for better control of the gate.
- Pb-free plating, halogen free mold compound
- Qualified for industrial grade applications according to JEDEC (J-STD20 and JESD22)



Benefits

- · Enabling higher system efficiency
- Enabling higher frequency / increased power density solutions
- System cost / size savings due to reduced cooling requirements
- Higher system reliability due to lower operating temperatures





Applications

PFC stages and hard switching PWM stages for e.g. Computing, Server, Telecom, UPS and Solar.

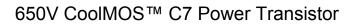
Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction.



Table 1 Key Performance Parameters

Table 1 1to y 1 of 10 mande 1 arameters							
Parameter	Value	Unit					
V _{DS} @ T _{j,max}	700	V					
R _{DS(on),max}	65	mΩ					
Q _{g.typ}	64	nC					
I _{D,pulse}	145	А					
E _{oss} @400V	8	μJ					
Body diode di/dt	60	A/µs					

Type / Ordering Code	Package	Marking	Related Links
IPZ65R065C7	PG-TO 247-4	65C7065	see Appendix A





IPZ65R065C7

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2 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

Davamatav	Cumbal	Values				Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Continuous drain current 1)	I _D	-	-	33 21	А	T _C =25°C T _C =100°C	
Pulsed drain current 2)	I _{D,pulse}	-	-	145	Α	T _C =25°C	
Avalanche energy, single pulse	E AS	-	-	171	mJ	I _D =10.2A; V _{DD} =50V; see table 10	
Avalanche energy, repetitive	E AR	-	-	0.85	mJ	I _D =10.2A; V _{DD} =50V; see table 10	
Avalanche current, single pulse	I _{AS}	-	-	10.2	Α	-	
MOSFET dv/dt ruggedness	dv/dt	-	-	100	V/ns	V _{DS} =0400V	
Gate source voltage (static)	V _{GS}	-20	-	20	V	static;	
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P _{tot}	-	-	171	W	<i>T</i> _C =25°C	
Storage temperature	$T_{ m stg}$	-55	-	150	°C	-	
Operating junction temperature	T _j	-55	-	150	°C	-	
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws	
Continuous diode forward current	I _S	-	-	33	Α	<i>T</i> _C =25°C	
Diode pulse current ²⁾	I _{S,pulse}	-	-	145	Α	T _C =25°C	
Reverse diode dv/dt ³⁾	dv/dt	-	-	1.5	V/ns	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <= $I_{\rm S}$, $T_{\rm j}$ =25°C see table 8	
Maximum diode commutation speed	di₁/dt	-	-	60	A/μs	$V_{\rm DS}$ =0400V, $I_{\rm SD}$ <= $I_{\rm S}$, $T_{\rm j}$ =25°C see table 8	
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	V _{rms} , T _C =25°C, t=1min	

 $^{^{1)}}$ Limited by $T_{j\,max}.$ $^{2)}$ Pulse width t_p limited by $T_{j,max}$ $^{3)}$ Identical low side and high side switch with identical $\textit{R}_{\textrm{G}}$



3 Thermal characteristics

Table 3 Thermal characteristics

Downworton	Cumbal	Values			11!4	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Thermal resistance, junction - case	R _{thJC}	-	-	0.73	°C/W	-	
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	°C/W	leaded	
Thermal resistance, junction - ambient for SMD version	R _{thJA}	-	-	-	°C/W	n.a.	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	-	-	260	°C	1.6mm (0.063 in.) from case for 10s	



4 Electrical characteristics at T_j =25°C, unless otherwise specified

Table 4 **Static characteristics**

Davamatav	Comple of		Values			N 4 4 7 4 8 1111	
Parameter	Symbol	Min.	Min. Typ. N		Unit	Note / Test Condition	
Drain-source breakdown voltage	V _{(BR)DSS}	650	-	-	V	V_{GS} =0V, I_D =1mA	
Gate threshold voltage	V _{(GS)th}	3	3.5	4	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=0.85{\rm mA}$	
Zero gate voltage drain current	I _{DSS}	-	- 15	1 -	μΑ	V _{DS} =650, V _{GS} =0V, T _j =25°C V _{DS} =650, V _{GS} =0V, T _j =150°C	
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V	
Drain-source on-state resistance	R _{DS(on)}	-	0.058 0.138	0.065	Ω	V _{GS} =10V, I _D =17.1A, T _j =25°C V _{GS} =10V, I _D =17.1A, T _j =150°C	
Gate resistance	R _G	-	0.85	-	Ω	f=1MHz, open drain	

Table 5 **Dynamic characteristics**

Davamatav	Cymphal	Values			11:4	Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	Ciss	-	3020	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz	
Output capacitance	Coss	-	48	-	pF	V _{GS} =0V, V _{DS} =400V, f=250kHz	
Effective output capacitance, energy related 1)	C _{o(er)}	-	100	-	pF	V _{GS} =0V, V _{DS} =0400V	
Effective output capacitance, time related	C _{o(tr)}	-	1110	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0400V	
Turn-on delay time	$t_{\sf d(on)}$	-	16	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9	
Rise time	t _r	-	7	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9	
Turn-off delay time	$t_{\sf d(off)}$	-	72	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9	
Fall time	t _f	-	7	-	ns	$V_{\rm DD}$ =400V, $V_{\rm GS}$ =13 V, $I_{\rm D}$ =17.1A, $R_{\rm G}$ =5.3 Ω ; see table 9	

Gate charge characteristics Table 6

Parameter	Cumbal	Values				Note / Test Condition	
raidilletei	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Gate to source charge	Q _{gs}	-	16	-	nC	V_{DD} =400V, I_{D} =17.1A, V_{GS} =0 to 10V	
Gate to drain charge	Q_{gd}	-	21	-	nC	V_{DD} =400V, I_{D} =17.1A, V_{GS} =0 to 10V	
Gate charge total	Q_g	-	64	-	nC	V_{DD} =400V, I_{D} =17.1A, V_{GS} =0 to 10V	
Gate plateau voltage	V _{plateau}	-	5.4	-	V	V_{DD} =400V, I_{D} =17.1A, V_{GS} =0 to 10V	

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 400V



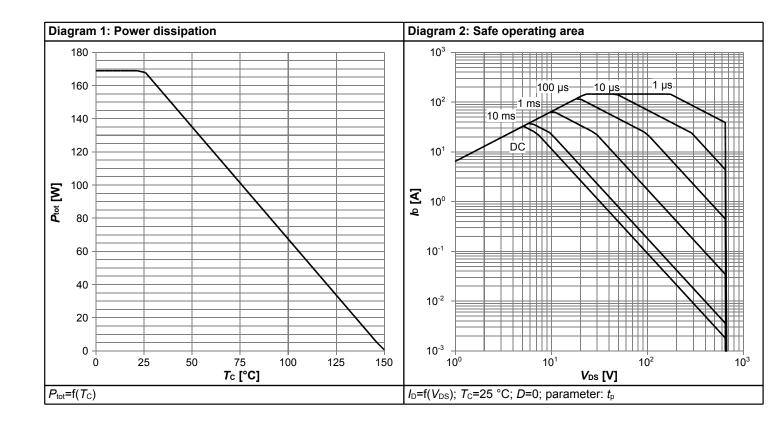
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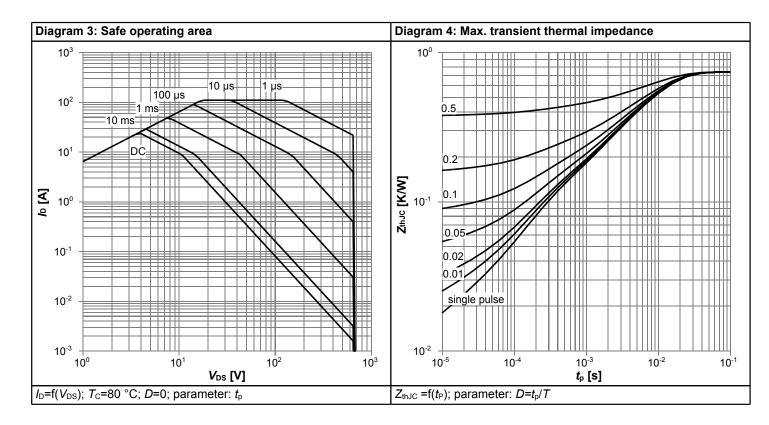
Table 7 Reverse diode characteristics

Davamatar	Cymbol		Values			Note / Test Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Diode forward voltage	V _{SD}	-	0.9	-	V	V _{GS} =0V, I _F =17.1A, T _j =25°C	
Reverse recovery time	t _{rr}	-	800	-	ns	V_R =400V, I_F =33A, di_F/dt =60A/ μ s; see table 8	
Reverse recovery charge	Q _{rr}	-	10	-	μC	V_R =400V, I_F =33A, di_F/dt =60A/ μ s; see table 8	
Peak reverse recovery current	I _{rrm}	-	30	-	А	$V_{\rm R}$ =400V, $I_{\rm F}$ =33A, $di_{\rm F}/dt$ =60A/ μ s; see table 8	

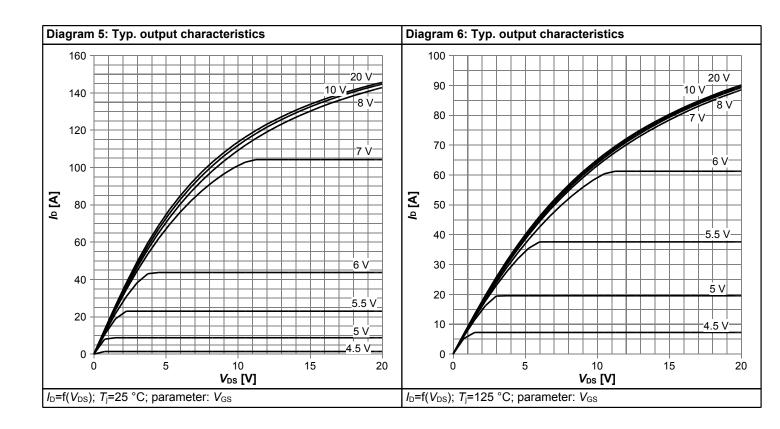


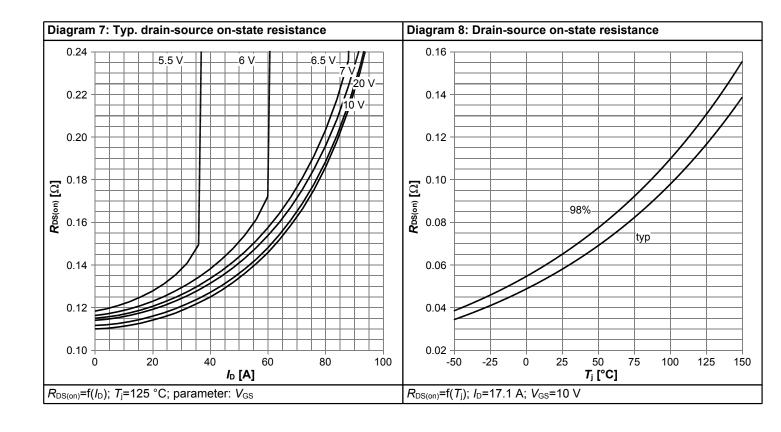
5 Electrical characteristics diagrams



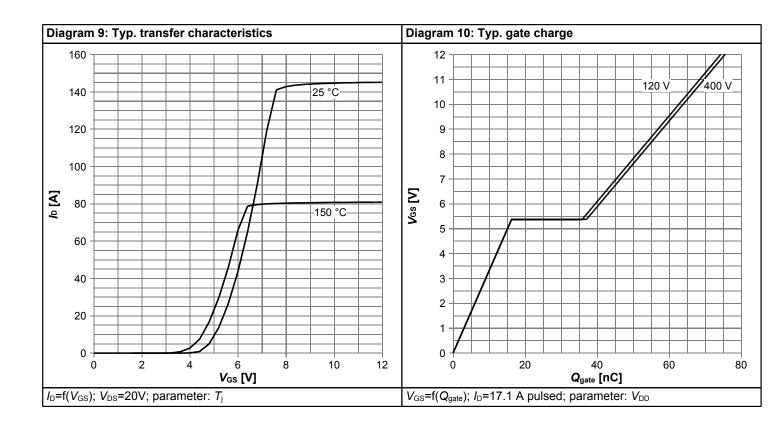


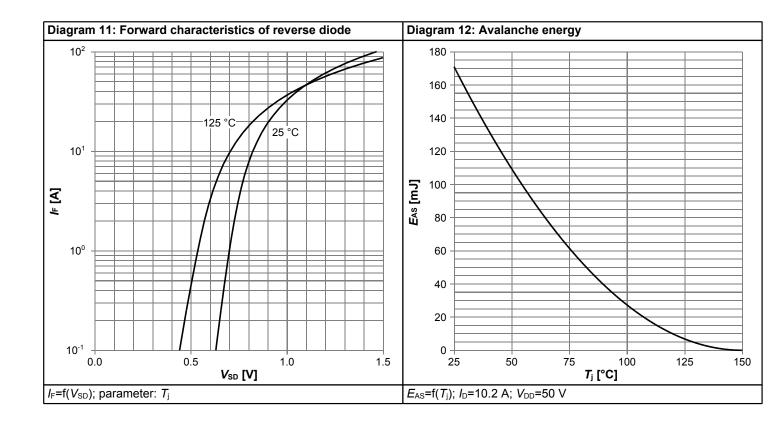




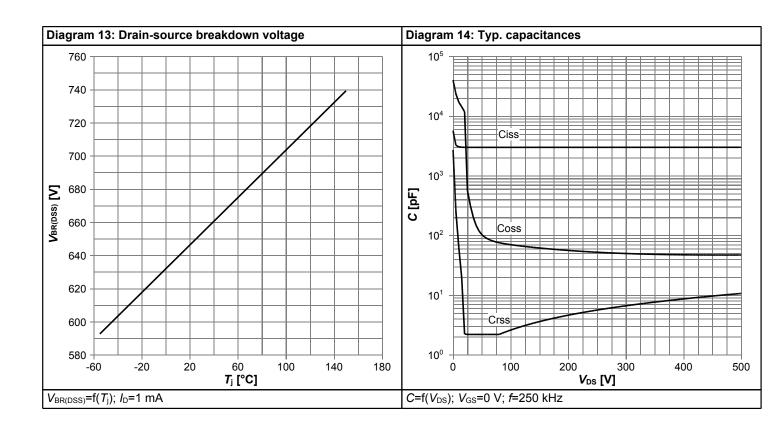


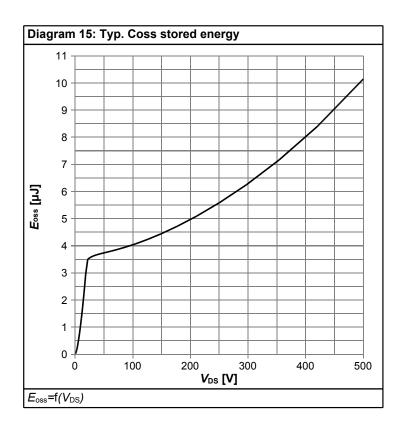














6 Test Circuits

Table 8 Diode characteristics

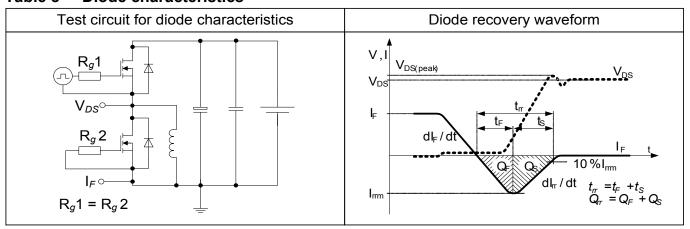


Table 9 switching times (ss)

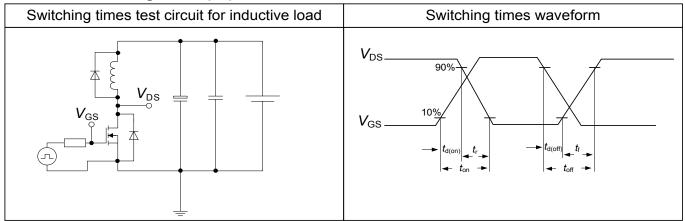
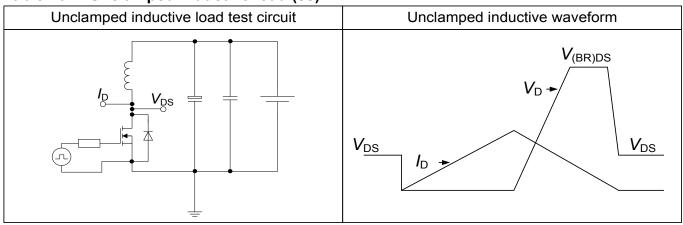
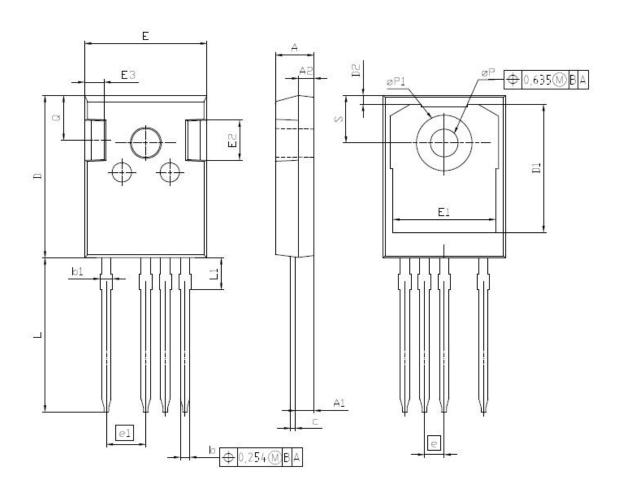


Table 10 Unclamped inductive load (ss)





7 Package Outlines



DIM	MILLIM	ETERS	INCI	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.83	5.21	0.190	0.205	
A1	2.29	2.54	0.090	0.100	
A2	1.90	2.16	0.075	0.085	
b	1.07	1.33	0.042	0.052	
b1	1.10	1.70	0.043	0.067	
С	0.50	0.70	0.020	0.028	
D	20.80	21.10	0.819	0.831	
D1	16.25	17.65	0.640	0.695	
D2	0.95	1.35	0.037	0.053	
E	15.70	16.13	0.618	0.635 0.557	
E1	13.10	14.15	0.516		
E2	3.68	5.10	0.145	0.201	
E3	1.00	2.60	0.039	0.102	
е	2.54 (BSC)		0.100 (BSC)		
e1	5.	08	0.2	00	
N		4		4	
L	19.72	20.32	0.776	0.800	
L1	4.02	4.40	0.158	0.173	
øР	3.50	3.70	0.138	0.146	
øP1	7.00	7.40	0.276	0.291	
Q	5.49	6.00	0.216	0.236	
S	6.04	6.30	0.238	0.248	

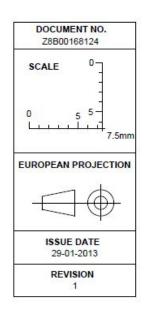


Figure 1 Outline PG-TO 247-4, dimensions in mm/inches



8 Appendix A

Table 11 Related Links

- IFX CoolMOS[™] C7 Webpage: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 application note: <u>www.infineon.com</u>
- IFX CoolMOS[™] C7 simulation model: www.infineon.com
- IFX Design tools: www.infineon.com



650V CoolMOS™ C7 Power Transistor

IPZ65R065C7

Revision History

IPZ65R065C7

Revision: 2013-10-18, Rev. 2.1

Previous Revision

1 TEVIOUS TVEVISION						
Revision	Date	Subjects (major changes since last revision)				
2.0	2013-10-11	Release of final version				
2.1	2013-10-18	final datasheet				

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